

Interconnection of ASUs CALICE meeting at CERN 21 May 2011 R.Poeschl P.Cornebise

Calorimeter for

Contents

- 1 Introduction
- 2 Current method of interconnection
- 3 PCB FEV interconnection with ACF 3M
 - 3.1 First test results from 3M Beauchamps (95)
 - 3.2 Second tests results from 3M Beauchamps
 - 3.3 Next steps

Introduction



2 Current method of interconnection



Kapton comb 1 connector



Solder bench



Silk screen for Manual solder paste laying (very delicate operation)



Halogen lamp for the solder 200°C for 2.30 minutes





We developed this method with the Cambridge University and used for interconnect 8 FEV temp

3 PCB FEV interconnection with ACF 3M Anisotropic Conductive Film adhesives ACF 7303 use characteristics



5

3.1 First test results from 3M Beauchamps (95)

Components

1 FEV7 CIP



1 Kapton comb 1 connector



ACF 3M 7303 film width=5mm length= 25meters



Miyachi thermode test bench



3M Adhesive has a lifetime of 30 days at room temperature if stored in a freezer

21/05/2011 PC LAL Instrumentation Électronique

3.1 Process

The ACF 3M looks like double-sided tape

Put the ACF on FEV Remove the protect film (brown)



Positioning of the comb (It's possible to repeat the positioning)





Using Myachi Thermode



Temperature 150°C Time 25 seconds Pressure 18 Bar

3.1 Results



Results of electrical test made with a precision multimeter Keithley Resistance between wires in PCB = 0.2 ohms Isolation between wires in PCB = ∞ Advantage of the ACF is:

- Ease to use, low stress for PCBs

- Industrialization of process is very easy

R&D issues:

- Currently limited information on the lifetime,
 - Requires further electrical and aging tests

3.2 Second test with the current thermode : Components



3.2 Preparation of test bench and interconnect

Positioning FEV8 3C to mechanical support



Put the ACF on boards and positioning kapton combs



The test was done last March at 3M Beauchamps with the help of R. Cornat LLR



21/05/2011 PC LAL Instrumentation Électronique

3.2 Results of the second test

- Problems encountered during the test, we struggled to achieve the interconnection due to the lack of mechanical support planéarity FEV8 3c, and a non-adaptability of the nozzle of the Myachi thermode for our boards.
- Due to this problem many connections are defective, as shown in the results table,(résults=values in ohms)(in red, bad values or not conduction)



3 PCB N° 1-2-3 with 2 ACE wire by wire							
A1-F1		A2-F2		A3-F3			
Wire	Résults	Wire	Résults	Wire	Résults	Wire	Résults
1	1.3	1	1.5	1	1.2	1	1.2
2	2.6	2		2	1.2	2	1.4
3		3		3	1.3	3	1.3
4	11	4		4	1.3	4	1.3
5		5		5	1.2	5	1.3
6	8	6		6	1.3	6	1.3
7		7		7	1.3	7	1.3
8		8		8	1.3	8	1.3
9	1.8	9		9	1.3	9	1.3
10		10		10	1.3	10	1.3
11		11		11	1.3	11	1.3
12		12	2.7	12	1.3	12	1.3
13		13		13	1.3	13	1.3
14		14		14	1.3	14	1.3
15		15		15	1.3	15	1.3
16	21.5	16		16	1.3	16	1.3
17		17		17	1.3	17	1.3
18		18		18	1.4	18	1.3
19		19	17	19	1.3	19	1.3
20		20		20	1.3	20	1.3
21		21		21	1.3	21	1.3
22		22		22	1.3	22	1.4
23		23		23	1.3	23	1.3
24		24		24	1.3	24	1.9
25		25		25	1.3	25	1.3
26		26		26	1.4	26	1.6
27		27		27	1.3	27	1.4
28		28		28	1.3	28	2.2
29		29		29	1.3	29	1.4
30		30		30	1.5	30	1.6
31		31		31	1.3	31	2
32		32		32	1.3	32	3.8
33		33		33	1.6	33	2.3
34		34	2.5	34	1.5	34	1.7
35	3.3	35		35	1.5	35	3.4
36	2.4	36	2.5	36	1.8	36	1.9

21/05/2011 PC LAL Instrumentation Électronique

3.3 Next steps

- Making a new support at LAL with a good planéarity.
- Use for the new test 3FEV8 3C with glued below the square glass or waffers from LLR & LPNHE to test the resistance to pressure when we use the Myachi thermode.
- The next test will be conducted at 3M Beauchamp (95) or Myachi at St Germain en Laye (78)
 but if we use this thermode unsuitable, we may have the same result, the easiest solution would be to make a thermode suited to our boards, but estimated costs, 15000 euros ...
- Buy a freezer to store ACF (and beers)
- These operations are not yet scheduled.





Thank's for your attention